

FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
T&A-105SERIAL NO.
09/810,195LIST OF DOCUMENTS CITED BY APPLICANT
(Use several sheets if necessary)APPLICANT
K. SEKINE et alFILING DATE
March 19, 2001GROUP
2682

U.S. PATENT DOCUMENTS

* EXAMINER	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
AA						
AB						
AC						
AD						
AE						
AF						
AG						
AH						
AI						
AJ						
AK						

RECEIVED

DEC 26 2002

Technology Center 2600

FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
CC	AL 0 064 000	11/03/82	Europe			<input type="checkbox"/>	<input checked="" type="checkbox"/>
	AM					<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

CC	AR	K. Ogawa et al, "A 50 GHz GaAs FET MIC Transmitter/Receiver Using Hermetic Miniature Probe Transitions", IEEE TRANSACTIONS ON MICROWAVE THEORY AND TECHNIQUES, September 1989, Vol. 37, No. 9, pp 1434-1441
CC	AS	Abstract of JP 05-267940, Published October 15, 1993, PATENT ABSTRACTS OF JAPAN, Vol. 018, No. 039
CC	AT	Abstract of JP 09-232825, Published September 5, 1997, PATENT ABSTRACTS OF JAPAN, Vol. 1998, No. 01

EXAMINER

DATE CONSIDERED

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. T&A-105	SERIAL NO. 09/810,195
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT K. SEKINE et al	
		FILING DATE March 19, 2001	GROUP 2817 2582

U.S. PATENT DOCUMENTS

* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
AA						
AB						
AC						
AD						
AE						
AF						
AG						
AH						
AI						
AJ						
AK						

FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
CC	AL 61-252702	11/10/86	Japan (w/abstract)			<input type="checkbox"/>	<input checked="" type="checkbox"/>
	AM					<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

AR	
AS	
AT	

EXAMINER

DATE CONSIDERED

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
T&A-105

SERIAL NO.

LIST OF DOCUMENTS CITED BY APPLICANT
(Use several sheets if necessary)APPLICANT
K. SEKINE et alFILING DATE
March 19, 2001GROUP
2682U.S. Pat. No. 6,972,810
09/810195
03/19/01**U.S. PATENT DOCUMENTS**

* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
CC	AL	11-154823	6/8/99	Japan			<input type="checkbox"/>	<input type="checkbox"/>
CC	AM	9-232825	9/5/97	Japan			<input type="checkbox"/>	<input type="checkbox"/>
CC	AN	5-267940	10/15/93	Japan			<input type="checkbox"/>	<input type="checkbox"/>
	AO						<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	AR		
	AS		
	AT		

EXAMINER

DATE CONSIDERED

W L

6-22-04

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.